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Applicant(s)/Patent under Reexamination HUANG ET AL.

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Examiner

Benjamin P. Geib

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| Class | Subclass | Date | Examiner |
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| Updated EAST search | 10/29/2007 | BPG |
| Updated NPL search (IEEE Xplore) | 10/29/2007 | BPG |
| Inventor name search | 10/29/2007 | BPG |
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